Seebeck Effects and Electronic Thermal Conductivity of IV-VI Materials

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Theoretical calculations of Seebeck coefficients and electronic thermal conductivity for general materials such as metals, semiconductors, and quantum structures are described, and dependence of the Seebeck coefficient on doping level and temperature is discussed for lead salt materials. Experimental Seebeck coefficient was measured for PbS films and the value agreed well with the theoretical one, indicating high thermoelectric performance comparable to PbTe. Temperature dependence of electronic thermal conductivity is also discussed for the lead salts. It is shown that minority carriers in the narrow gap semiconductor significantly affect the electronic thermal conductivity and electronic thermal conductivity at high temperature can be reduced by highly doping.
1. Introduction

Developments of materials with high thermoelectric conversion efficiency are important for energy and environmental issues. Dimensionless figure of merits $ZT = S^2\sigma T/\kappa$ or power factor $P_f = S^2\sigma$, where $S$ is the Seebeck coefficient, $\sigma$ the electrical conductivity, and $\kappa$ the thermal conductivity, are used as indicators of the conversion efficiency. Among the parameters, thermal conductivity is an important parameter because the reduction of thermal conductivity increases the $ZT$ and furthermore reduces the necessary amount of the material for device fabrication. Introduction of nanostructure is efficient to reduce the thermal conductivity.\textsuperscript{1-3} Seebeck coefficient is another important factor because it has the effect of second power on the efficiency. Various materials and quantum structures have been reported as high efficiency thermoelectric materials,\textsuperscript{1-5} and theoretical calculations of Seebeck coefficients through band structure calculations have been also performed. In the theoretical calculation Mott formula is usually used to predict the Seebeck coefficient of metals,\textsuperscript{6} and the formula is sometimes used to discuss the Seebeck coefficients of semiconductors and quantum wells qualitatively.\textsuperscript{7,8} Recently, first principle calculations for band structures of complicated material systems and quantum wells are available owing to the developments of computers,\textsuperscript{9,10} and these calculations are becoming important to predict high efficiency thermoelectric materials. In this paper, first, we describe theoretical calculations of Seebeck coefficients and electronic thermal conductivity for general materials such as metals,
semiconductors, and quantum structures on the basis of solid state physics, which would be useful for both theoretical and experimental thermoelectric researchers. Next, we discuss Seebeck coefficient and electronic thermal conductivity of lead salt IV-VI materials.

2. Theoretical Calculations of Seebeck Coefficient and Electronic Thermal Conductivity

Figure 1 shows schematic carrier distribution on energy and carrier flows in n-type semiconductors under temperature gradient. The Seebeck coefficient is determined by the equation:

\[ S = \left( \frac{1}{e} \right) \frac{dE_F}{dT} = \left( \frac{1}{e} \right) \frac{d(E_C - E_F)}{dT} + \left( \frac{1}{e} \right) \frac{dE_C}{dT}, \quad (1) \]

where \( E_F \) and \( E_C \) are the Fermi level and conduction band edge energy, respectively. The first term on the right side of the equation is determined by the density of states, and the second term is determined by the balance between drift and thermal diffusion currents: \( \sum J_{ed} + J_{dt} + J_{hd} + J_{ht} = 0 \), where \( J_{ed} \) and \( J_{hd} \) represent drift current densities for electrons and holes, respectively, and \( J_{et} \) and \( J_{ht} \) represents thermal diffusion currents for the electrons and holes, respectively. In general, the total current density is given by the equation below under the background of solid-state physics and Boltzmann equation\(^{11} \)

\[ J = \frac{e^2}{4\pi^2 kT} \frac{dT}{dx} \sum \sqrt{\pi} f_y (1 - f_y) \left( \frac{E - E_F}{eT} + \frac{1}{e} \frac{dE_F}{dT} \right) d^3k, \quad (2) \]
where the summation is taken for all energy bands related to the conductions. The equation for the Seebeck coefficient $S$ is obtained from the condition $J=0$:

$$S = \frac{-1}{eT} \sum_{V} \int \frac{\tau \nu_{x}^{2} f_{0}(1-f_{0})(E(k)-E_{F})d^{3}k}{\sum_{V} \int \nu_{x}^{2} f_{0}(1-f_{0})d^{3}k},$$

where $\tau$ is the scattering time of carrier, $\nu_{x}$ the electron velocity along temperature gradient, $f_{0}$ is the Fermi-Dirac distribution. In the calculation, phonon-drag effect in which phonon flow causes significant enhancement of the Seebeck coefficient at low temperature is not considered. After integrations over the constant energy surfaces, the equation becomes the following energy integral:

$$S = \frac{-1}{eT} \sum_{V} \int \frac{\tau \nu_{x}^{2} f_{0}(1-f_{0})(E-E_{F})D(E)dE}{\sum_{V} \int \tau \nu_{x}^{2} f_{0}(1-f_{0})D(E)dE},$$

where $D(E)$ is the density of states in the $V$-th valley and $\nu_{x}^{2}(E)$ is the value given by

$$\nu_{x}^{2}(E) = \frac{1}{S_{k}} \int v_{x}^{2}(k)d^{2}k.$$

Here, $S_{k}$ represents the area of constant energy surface with energy $E$ in the $V$-th valley.

For simple metal with parabolic band, Eq.(4) becomes Mott formula:
\[ S_{\text{metal}} \approx \frac{1}{eT} \left[ \int_{-\infty}^{E_F} f_0 \left( 1 - f_0 \right) (D(E))_{E=E_F} \left( E - E_F \right)^2 dE \right] \]

\[ \approx -k^2 T \int_{-\infty}^{E_F} \frac{x^2 e^x}{\left( 1 + e^x \right)^2} dx \]

\[ = -\pi^2 k^2 T \frac{\int \ln N(E)}{3e} \bigg|_{E=E_F} = -\pi^2 k^2 T \frac{\int \ln \sigma(E)}{3e} \bigg|_{E=E_F} \]

where we assumed \( \tau \) is constant and replaced \( (E - E_F)/kT = x \). In the calculation, we also used \( \frac{\partial}{\partial E} (E) \propto E \), 

\[ D(E) = \frac{dN(E)}{dE} = 3N(E)/2E \]

in which \( N(E) \) is the number of states below \( E \), and we put

\[ N(E) \approx N(E_F) + (dN/dE)_{E=E_F} \left( E - E_F \right) \]

and \( \sigma(E) = e^2 \tau N(E)/m \).

Detailed calculation is discussed in Ref. 13. In general, band structure of metals are more complicated and it is necessary to calculate the Seebeck coefficient from Eq. (4) in the case many valleys affect the conductivity.

The Mott formula is not applicable for semiconductors and superlattices. The Seebeck coefficients must be calculated from Eq. (3) or (4). In semiconductors and semimetals, constant energy surface near the Fermi energy often becomes rotational ellipsoid with longitudinal effective mass \( m_l \) and transverse effective mass \( m_t \), and \( \bar{\nu}_X^2(E) \) is written as

\[ \bar{\nu}_X^2(E) = \frac{2}{3} \left( \frac{\cos^2 \phi}{m_l} + \frac{\sin^2 \phi}{m_t} \right) E \]
where $E$ is measured from the band edge, and $\phi$ is the angle between the longitudinal direction and temperature gradient. In narrow gap semiconductors and semimetals, the $E$-$k$ relationship is often represented by $E(1 + E/E_g) = \sum \hbar^2 k^2 / 2m_j$ in two band flame work, and density of states $D(E)$ and $v_x^2(E)$ are given by

$$D(E) = \sqrt{\frac{2m_i^2 m_j E(1 + \frac{E}{E_g})(1 + 2\frac{E}{E_g})}{\pi^2 \hbar^3}}.$$  \hspace{1cm} (8)

and

$$v_x^2(E) = \frac{2}{3} \left( \frac{\cos^2 \phi}{m_i} + \frac{\sin^2 \phi}{m_j} \right) \frac{E(1 + E/E_g)}{(1 + 2E/E_g)^2}.$$  \hspace{1cm} (9)

In many valley semiconductors such as lead−salt IV-VI materials, n-type Ge, or n-type Si, there is no directional dependence of Seebeck coefficient under no strain, because the summation below shows no directional dependence.

$$\sum_{\nu} \left( \frac{\cos^2 \phi}{m_i} + \frac{\sin^2 \phi}{m_j} \right) = M \left( \frac{1}{3m_i} + \frac{2}{3m_j} \right).$$  \hspace{1cm} (10)

However, if electron distribution in each valley is varied by strain, directional dependence appears.

Figure 2 shows conduction band densities of states for bulk, two-dimensional, and one-dimensional Si. In the bulk, two-dimensional, and one-dimensional systems for the host
materials with parabolic $E^2$ relationship, the Seebeck coefficients are given by a simple equation:

$$
S = -\frac{1}{eT} \int_0^\infty f_0(l-f_0)E'(E-E_F)dE \int_0^\infty f_0(l-f_0)E'dE,
$$

(11)

where $s$ is constant depending on the material system.

Assuming $\tau(E) \propto E^{-1/2}$ for optical phonon scattering, and $v_x^2 \propto E$, $s$ becomes 1 for bulk materials, and $s=1/2$ for two dimensional system, and $s=0$ for one-dimensional system, depending on the densities of states for bulk, two-dimensional, and one-dimensional systems. If more than two type of carriers or quantum levels affect the conduction, summation given by Eq.(4) is necessary. Since the Seebeck coefficient is given by an average value of $(E_F-E)/eT$, it strongly depends on the carrier concentration, and if the carrier concentration is same, the materials with large density of states have higher Seebeck coefficient. In low dimensional systems such as superlattice, enhancement of Seebeck coefficient is possible owing to a high and step-like density of states. However, a high density of quantum structures is necessary to obtain enhanced Seebeck coefficient and resultant higher thermoelectric performance compared to bulk materials since the density of states $D(E)$ is proportional to the density of quantum structures. Other possibilities to enhance the Seebeck effect are filtering effects of carriers, caused at the boundary of nanostructures, caused by strain in many valley semiconductors and effective mass modulation in
superlattice. In this calculation we did not consider phonon drag effect, which increases the Seebeck coefficient of the material with long phonon mean free path such as Si. In nanostructures such as Si nanowire, mean free path of phonon is restricted strongly by the interface or surface scattering. Thus phonon-drag effect is strongly reduced.

For the materials with low lattice thermal conductivity or metals, carrier contribution to the thermal conductivity becomes important. The electronic part to the thermal conductivity is calculated by considering the energy transfer of each electron under the condition $J=0$ in the Eq.(2). The energy carried by one electron may be considered to be $E-E_{0V}$ where $E_{0V}$ is the average energy of electrons in the valley $V$. However, the correct energy is $E-E_F$ taking into account the recombination of excess carriers caused by the multiple carrier flow. Thus we can calculate the total energy transfer or thermal conductivity by multiplying $(E-E_F)/e$ in the integral of Eq.(2) as given by

$$\kappa_e = \frac{1}{4\pi k T^2} \left[ \sum_r \pi^2 f_0 (1-f_0)(E(k)-E_F)^2 d^3k - e^2S^2T^2 \sum_r \pi^2 f_0 (1-f_0)d^3k \right]$$

$$= \frac{1}{e^2T^2} \left[ \sum_r \pi^2 f_0 (1-f_0)(E-E_F)^2 d^3k \right] \left[ \sum_r \pi^2 f_0 (1-f_0)d^3k \right] - S^2 \right]. \quad (12)$$

IV-VI materials such as PbTe, PbSe, and PbS have small lattice thermal conductivity as low as 2 W/mK at low temperature and relatively high carrier mobility. Thus the electronic thermal conductivity becomes important.
3. Seebeck Coefficients and Electronic Thermal Conductivity of IV-VI Materials

Figure 3 (a) shows the dependence of Seebeck coefficients on donor and acceptor concentrations for PbS, PbTe, and EuTe/PbTe superlattices at 300K, and Fig. 3(b) shows temperature dependence of Seebeck coefficient for PbTe and PbS. The dots ⃗, ⃗⃗, and ⃗⃗⃗ indicates the experimental data for PbS, PbTe, and EuTe/PbTe superlattices, respectively, and solid, dashed, and dashed-dotted lines indicates theoretical dependence for PbS, PbTe, and EuTe/PbTe superlattice, respectively. Detailed calculations and parameters for the PbTe and EuTe/PbTe superlattice are given in Ref. 11. Band gaps and effective mass parameters for PbS and PbTe are indicated in table I.\textsuperscript{17,18} We used same effective masses for conduction and valence band of PbS owing to almost symmetric band edge structures at L-point. The Seebeck coefficients of the n-type and p-type PbTe films, and n-type EuTe/PbTe superlattices have been reported before.\textsuperscript{11,14} Enhancement of Seebeck coefficient in the EuTe/PbTe superlattices were obtained through the modulation of the density of states.\textsuperscript{14} The Seebeck coefficient of p-type PbTe was higher than that of n-type owing to indirect valence band extrema near the L-point valence band tops.\textsuperscript{11} Measurement system for the PbTe films and superlattices has been described in Ref.14. Experimental setup for the temperature dependence of Seebeck coefficient for PbS is shown in Fig.4. The sample film was contacted by pushing the sample on the Cu heat sink, and the temperatures of sample in both sides were
measured by Cu-Constantan thermocouples buried in the heat sink. Seebeck voltage was measured by measuring the voltage between Cu lines in high and low temperature sides.

Theoretical values for PbS films at 300K agreed well with the experimental ones as well as PbTe and EuTe/PbTe superlattice. Seebeck coefficient of the n-type PbS was higher than that of PbTe, since PbS has large density of states compared to PbTe due to large effective masses. On the other hand, Seebeck coefficient of p-type PbS was comparable to that of p-type PbTe, and absolute value of the Seebeck coefficient for the p-type PbS was comparable to that of n-type PbS owing to the symmetric band structure with small higher band effect. In the temperature dependence of Seebeck coefficient shown in Fig.3(b), experimental values for the n-type PbS agreed well with the theoretical values with relatively high Seebeck coefficient compared with theoretical values for PbTe. The PbTe has been utilized as good thermoelectric materials with small thermal conductivity. However, Te is not abundant in the earth. Thus PbS is preferable if the comparable ZT is obtained for PbS.

Lattice thermal conductivity of IV-VI materials such as PbTe, PbSe, and PbS has the value 2W/mK at room temperature, and the value decreases with the temperature. Electronic thermal conductivity becomes important for the IV-VI materials owing to the small lattice thermal conductivity, and the electronic thermal conductivity is calculated from Eq.(12). Figure 5(a) shows the calculated dependence of electronic thermal conductivity on temperature for n-type PbTe with the parameter of carrier
concentration. At room temperature, the electronic thermal conductivity is almost proportional to the carrier concentration as expected. In simple consideration, electronic thermal conductivity decreases with temperature owing to rapid decrease of carrier mobility. However, an enhancement of thermal conductivity with temperature is predicted by the theoretical calculation. This is considered to be due to a minority carrier effect. Minority carrier concentrations for the PbTe films with $N_D=1 \times 10^{19}$, $5 \times 10^{18}$, $1 \times 10^{18}$, and $1 \times 10^{17}\text{cm}^{-3}$ are estimated to be $2.5 \times 10^{17}$, $4.7 \times 10^{17}$, $1.2 \times 10^{18}$, and $1.6 \times 10^{18}\text{cm}^{-3}$ at 800K, respectively. The enhancement of total carrier concentration is significant for low carrier concentration films. However, the lower thermal conductivity in higher carrier concentration film at high temperature in Fig.5(a) cannot be explained only by the carrier concentration enhancement. At low temperature, minority carrier concentration is negligibly small, and energy transfer or electronic thermal conduction occurs under the balance of thermal diffusion and drift currents, conducting relatively small energy. However, in two carrier conduction at high temperature, thermal diffusion current and drift current have the same direction for the minority carrier as shown in Fig.1, and balance between thermal diffusion current ($J_{ei}$) and drift current ($J_{ed}$) in the majority carrier is broken. Thus higher thermal flow is caused in the two carrier conduction because of the same directional flows of electrons and holes. The additional thermal flow is simply estimated to be $(E_g+3kT)(J_{ea}+J_{eh})/e$ as the energy generated by the electron-hole recombinations, and the value becomes significant even if the minority carrier concentration is
relatively low, because the interband transition energy $E_g + 3kT$ is much higher than the intraband transition energy proportional to $kT$.

Enhancements in lattice thermal conductivity at high temperature have been reported for various materials. However, the enhancement of the thermal conductivity may be due to the electronic part derived here. Figure 5(b) shows comparison of electronic thermal conductivities for n-type PbTe, and n, p-type PbS with carrier concentration of $1 \times 10^{19}$ cm$^{-3}$. In this calculation, we assumed room temperature carrier mobilities 1500, 750, 600, and 600 cm$^2$/Vs for n-type PbTe, p-type PbTe, n-type PbS, and p-type PbS, respectively, and temperature dependence $\mu(T) \propto T^{-2.5}$ for all the materials. The theoretical value for n-type and p-type PbS is the same because they have the same carrier mobility and effective masses. Among lead salt materials such as PbTe, PbSe, and PbS, enhancement of the electronic thermal conductivity is highest in PbTe, because of temperature independent band gap above 400K, owing to direct gap to indirect gap transition, and smallest in PbS owing to positive temperature dependence of band gap with relatively large value and small carrier mobility. Thermoelectric figure of merits for n-type PbTe and n-type PbS were calculated in the temperature range of 300-800K assuming lattice thermal conductivity $\kappa_L \propto T^{-1.5}$. Figure 6 shows the calculated ZTs for the materials. Expected ZT for p-type PbS is the same with n-type PbS because Seebeck coefficients and carrier mobilities are almost same for n-type and p-type PbS. PbS has smaller ZT than PbTe at room temperature owing to small carrier mobility. However, the ZT increases strongly
with temperature, and it has comparable values with PbTe around 600-800K. Thus PbS is expected as good thermoelectric materials in this temperature range.

4. Summary

We described general calculations of Seebeck effect including metals, semiconductors, and quantum structures, which would be useful for both theoretical and experimental thermoelectric researchers. Mott formula is satisfied in simple metal approximation. The calculations for many valley semiconductors and nonparabolic cases were also described, and it was discussed how directional dependence appears in Seebeck coefficients. Theoretical calculations of Seebeck coefficient and electronic thermal conductivity were performed for IV-VI materials. Theoretical Seebeck coefficients of p- and n-type PbS agreed well with experimental values as well as PbTe films and EuTe/PbTe superlattices. In IV-VI narrow gap materials, electronic part of thermal conductivity becomes important, and significant enhancement of thermal conductivity is caused by the minority carriers.

Acknowledgements

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References


### Table I  Band parameters used for the theoretical calculations in PbS.\(^{17,18}\)

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<th>(E_g(T)) [meV]</th>
<th>(m_l(0)) [(m_0)]</th>
<th>(m_l(T)) [(m_0)]</th>
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</thead>
<tbody>
<tr>
<td>PbS</td>
<td>(263+(400+0.256T^2)^{1/2})</td>
<td>0.08</td>
<td>0.105</td>
<td>(\frac{E_{gl}(T)}{E_{gl}(0)}m_l(0))</td>
</tr>
<tr>
<td>PbTe</td>
<td>(167+(400+0.256T^2)^{1/2})</td>
<td>0.024</td>
<td>0.24</td>
<td>(\frac{E_{gl}(T)}{E_{gl}(0)}m_l(0))</td>
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<td></td>
<td><strong>Indirect gap:</strong> 370</td>
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<td><strong>for T&gt;400K</strong></td>
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Figure Captions

**Fig.1** Schematic diagram of electron and hole distribution on energy under temperature gradient. The $J_{ed}$ and $J_{hd}$ represent drift current densities for electrons and holes, respectively, and $J_{et}$ and $J_{ht}$ represents thermal diffusion currents for electrons and holes, respectively.

**Fig.2** Conduction band densities of states for bulk Si, two-dimensional system grown to [111] direction with $10^6$ quantum wells/cm, and one-dimensional system with $10^{12}$ wires/cm$^2$.

**Fig.3** (a) the dependence of Seebeck coefficient on donor and acceptor concentrations for PbS, PbTe,$^{11,14}$ and EuTe/PbTe superlattice$^{14}$ at 300K, and (b) the temperature dependence of Seebeck coefficient for PbTe and PbS with a carrier concentration of $1 \times 10^{19}$cm$^{-3}$. The dots $\square$, $\triangle$, and $\blacksquare$ indicates the experimental data for PbS, PbTe, and EuTe/PbTe superlattices, respectively, and solid, dashed, and dashed-dotted lines indicates theoretical dependence for PbS, PbTe, and EuTe/PbTe superlattice, respectively.

**Fig.4** Seebeck voltage measurement system used to measure the temperature dependence of Seebeck coefficient of PbS.

**Fig.5** (a) Dependence of electronic thermal conductivity on temperature for n-type PbTe with the parameter of carrier concentration, and (b) comparison of electronic thermal conductivities for n, p-type PbTe, and n, p-type PbS with a
carrier concentration of $1 \times 10^{19}$ cm$^{-3}$.

**Fig.6** Thermoelectric figure of merits for (a) n-type PbTe and (b) n-type PbS in the temperature range of 300-800K with 100K step, calculated assuming temperature dependent lattice thermal conductivity $\kappa_L \propto T^{-1.5}$ and carrier mobility $\mu \propto T^{-2.5}$. 
Fig. 3

(a) Seebeck coefficient (µV/K) vs. \(N_D - N_A\) (cm\(^{-3}\)) at 300K

(b) Seebeck coefficient (µV/K) vs. Temperature (K)

- p-PbTe
- n-PbTe
- EuTe/PbTe [100] 0.66/5nm
- p-PbS
- n-PbS

Numbers:
- \(N_A = 1 \times 10^{19}\) cm\(^{-3}\)
- \(N_D = 1 \times 10^{19}\) cm\(^{-3}\)
Fig. 4

Temperature controlled furnace with N2 gas inside
Fig. 5

(a) n-type PbTe

(b) $N_D = 1 \times 10^{19}$ cm$^{-3}$

Temperature (K)

- $n$-PbTe
- $p$-PbTe
- n,p-PbS
Fig. 6

(a) n-PbTe

(b) n-PbS